Intelligent Big Data Analysis for High-Dimensional Internet of Things

Guest Editors:

Dr. Wanfu Gao
College of Computer Science and Technology, Jilin University, Jilin 130012, China

Dr. Yuzhou Liu
College of Computer Science and Technology, Jilin University, Jilin 130012, China

Dr. Ping Zhang
School of Artificial Intelligence, Hebei University of Technology, Tianjin 300401, China

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Message from the Guest Editors

Intelligent Big Data Analysis for High-Dimensional Internet of Things (IoT) is a complex and critical area of research that demands interdisciplinary expertise in data science, machine learning, and IoT. This Special Issue will supplement the existing literature by providing a platform for the latest research and advancements in intelligent big data analysis for high-dimensional IoT. It will also provide insights into the challenges and opportunities of this area of research and suggest future research directions.

The scope of this Special Issue is broad and encompasses various domains related to IoT, such as smart cities, healthcare, transportation, and industrial automation. It includes topics such as big data analytics, machine learning, data mining, natural language processing, and deep learning. The Special Issue will be a valuable resource for researchers, practitioners, and industry experts working in the field of IoT and data analytics.

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Special Issue

Editor-in-Chief

Prof. Dr. Flavio Canavero
Department of Electronics and
Telecommunications,
Politecnico di Torino, 10129
Torino, Italy

Message from the Editor-in-Chief

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